File for reference only

**SCHEDULE LXIII – EGYPT**

25 July 2018

**SCHEDULE LXIII - EGYPT**

**PART I - MOST-FAVOURED NATION TARIFF**

**SECTION II – Other Products**

| **Tariff item (HS2007)** | **Description of Products** | **Base  rate  of duty** | **Bound  rate  of duty** | **Implementation period from/to (\*)** | **Initial Negotiating Right** | **Other duties and charges** |
| --- | --- | --- | --- | --- | --- | --- |
| 8421 | Centrifuges, including centrifugal dryers; filtering or purifying machinery and apparatus, for liquids or gases. |  |  |  |  |  |
| 84219 | - Parts: |  |  |  |  |  |
| 84219100 | - Parts and accessories |  | Unbound |  |  |  |
| 8529 | Parts suitable for use solely or principally with the apparatus of headings 85.25 to 85.28. |  |  |  |  |  |
| 852990 | - Other |  |  |  |  |  |
| 85299090 | - - Other |  |  |  |  |  |
| 85299090 ex | --- Parts of:       transmission apparatus other than apparatus for radio- broadcasting or television;  transmission apparatus incorporating reception apparatus;  digital still image video cameras;  portable receivers for calling, alerting or paging. |  | 0 |  |  | 0 |
| 85299090 ex | - - - Other |  | Unbound |  |  |  |
| 9031 | Measuring or checking instruments, appliances and machines, not specified or included elsewhere in this Chapter; profile projectors. |  |  |  |  |  |
| 903190 | - Parts and accessories |  |  |  |  |  |
| 90319010 | - - Parts and accessories of optical instruments and appliances for inspecting semiconductor wafers or devices or for inspecting masks, photomasks or reticles used in manufacturing semiconductor devices |  | 0 |  |  | 0 |
| 90319020 | - - Parts and accessories of optical instruments and appliances for measuring surface particulate contamination on semiconductor wafers |  | 0 |  |  | 0 |
| 90319090 | - - Other |  | Unbound |  |  |  |

**\_\_\_\_\_\_\_\_\_\_\_\_\_\_**